Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/735,392	HANNAWA ET AL.
Examiner	Art Unit

M. Safavi

3673

SEARCHED				
Class	Subclass	Date	Examiner	
249	15, 16, 140, 112	2/25/2006	ml	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
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